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A WINTER	/Betty Forman/	DATE CONSIDERED	00/04/0007
			09/04/2007

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FORM PTO-1449 (Rev. 2-32)	SECOND SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)	Atty. Docket No.	Serial No. 10/757,780
(B DEC 1 2 2005 &		Applicant: William Cork et al.	
A PARTIE NAME OF THE		Filing Date: January 15, 2004	Group: 1637

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/BF/	1.	6,248,988	6-19-2001	Krantz	250	201.3	5-5-1998
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/BF	/2.	WO 99/13319	3-18-1999	PCT	G01N	21/55		
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FORM PTO-1449 (Rev. 2-32) THIRD SUPPLEM INFORMATION DIS STATEMENT BY AI (Use several sheets if	CLOSURE PPLICANT	Atty. Docket No.	Serial No. 10/757,780
		Applicant: Patno et al.	
	*	Filing Date: January 15, 2004	Group: 1637

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/BF/	1.	20030224505	Dec. 4, 2003	Patno et al.	435	287.2	Jan. 27, 2003
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(Use as many sheets as necessary)

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Examiner Name T.B.A. Attorney Docket Number 101-801-C

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xaminer nitials*	Cite No.1	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Ciled Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/BF/	1	us-5;018;219	05-21-1991	- Matsuzaki et al.	
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Examiner Initials*	Cite No.1	Foreign Patent Document Country Code ³ "Number ⁴ "Kind Code ⁵ (<i>If Isnown</i>)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
/BF/	9	WO 02/086468	10-31-2002	Kempen, Lothar, U.	•			
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$\overline{}$	11	WO 03/060446	07-24-2003	Lieberman et al.				
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Examiner Signature	/Betty Forman/	Date Considered	09/04/2007

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Subs	titute for form 1449B/PTO			Complete if Known		
				Application Number	10/757,780	
IN	FORMATION DIS	CLOS	URE	Filing Date	January 15, 2004	
ST	ATEMENT BY AF	PLIC	ANT	First Named Inventor	Tim Patno	
				Art Unit	1637	
	(Use as many sheets as ned	essary)		Examiner Name	T.B.A.	
Sheet	2	of	2.	Attorney Docket Number	01-801-C	

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Examiner Signature	/Betty Forman/	Date Considera	09/04/2007

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U.S. Department of Commerce Patent and Trademark Office Atty. Docket No.
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Serial No.

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT BY APPLICANT

10/757,780

Applicant: Patno et al.

Filing Date: January 15, 2004 Group: 1637

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Examiner DUPLICATE CITATIONS /Betty Forman/	Date Considered 09/04/2007
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